FSQ0365RN, FSQ0265RN, FSQ0165RN, FSQ311 Green Mode Fairchild Power Switch (FPS™) for QRC



November 2006

# FSQ0365RN, FSQ0265RN, FSQ0165RN, FSQ311 Green Mode Fairchild Power Switch (FPS<sup>™</sup>) for Quasi-Resonant Operation - Low EMI and High Efficiency

## Features

- Optimized for Quasi-Resonant Converter (QRC)
- Low EMI through Variable Frequency Control and Inherent Frequency Modulation
- High-Efficiency through Minimum Voltage Switching
- Narrow Frequency Variation Range over Wide Load and Input Voltage Variation
- Advanced Burst-Mode Operation for Low Standby Power Consumption
- Pulse-by-Pulse Current Limit
- Various Protection Functions: Overload Protection (OLP), Over-Voltage Protection (OVP), Abnormal Over-Current Protection (AOCP), Internal Thermal Shutdown (TSD)
- Under-Voltage Lockout (UVLO) with Hysteresis
- Internal Start-up Circuit
- Internal High-Voltage Sense FET (650V)
- Built-in Soft-Start (15ms)

## Applications

- Power Supply for DVP Player and DVD Recorder
- Power supply for Set-Top Box
- Adapter
- Auxiliary Power Supply for PC, LCD TV, and PDP TV

## Description

A Quasi-Resonant Converter (QRC) generally shows lower EMI and higher power conversion efficiency than a conventional hard-switched converter with a fixed switching frequency. The FSQ-series is an integrated Pulse-Width Modulation (PWM) controller and SenseFET specifically designed for quasi-resonant operation with minimal external components. The PWM controller includes an integrated fixed-frequency Under-Voltage Lockout, oscillator. Leading Edge Blanking (LEB), optimized gate driver, internal soft-start, temperature-compensated precise current sources for loop compensation, and self-protection circuitry. Compared with discrete MOSFET and PWM controller solution, the FSQ-series can reduce total cost, component count, size and weight; while simultaneously increasing efficiency, productivity, and system reliability. This device provides a basic platform that is well suited for cost-effective designs of quasi-resonant switching flyback converters.

				R <sub>DS(ON)</sub>	Maximum Output Power <sup>(1)</sup>				
Product		Operating	Current		230V <sub>AC</sub> ±15% <sup>(2)</sup>		85-265V <sub>AC</sub>		Replaces
Number <sup>(5)</sup>	1 1.0.	Temp.			Adapter <sup>(3)</sup>	Open Frame <sup>(4)</sup>	Adapter <sup>(3)</sup>	Open Frame <sup>(4)</sup>	Devices
FSQ311	8-DIP	-25 to +85°C	0.6A	19Ω	7W	10W	6W	8W	FSDL321 FSDM311
FSQ0165RN	8-DIP	-25 to +85°C	0.9A	10Ω	10W	15W	9W	13W	FSDL0165RN
FSQ0265RN	8-DIP	-25 to +85°C	1.2A	6Ω	14W	20W	11W	16W	FSDM0265RN FSDM0265RNB
FSQ0365RN	8-DIP	-25 to +85°C	1.5A	4.5Ω	17.5W	25W	13W	19W	FSDM0365RN RSDM0365RNB

## **Ordering Information**

Notes:

1. The junction temperature can limit the maximum output power.

2. 230VAC or 100/115VAC with doubler. The maximum power with CCM operation.

3. Typical continuous power in a non-ventilated enclosed adapter measured at 50°C ambient temperature.

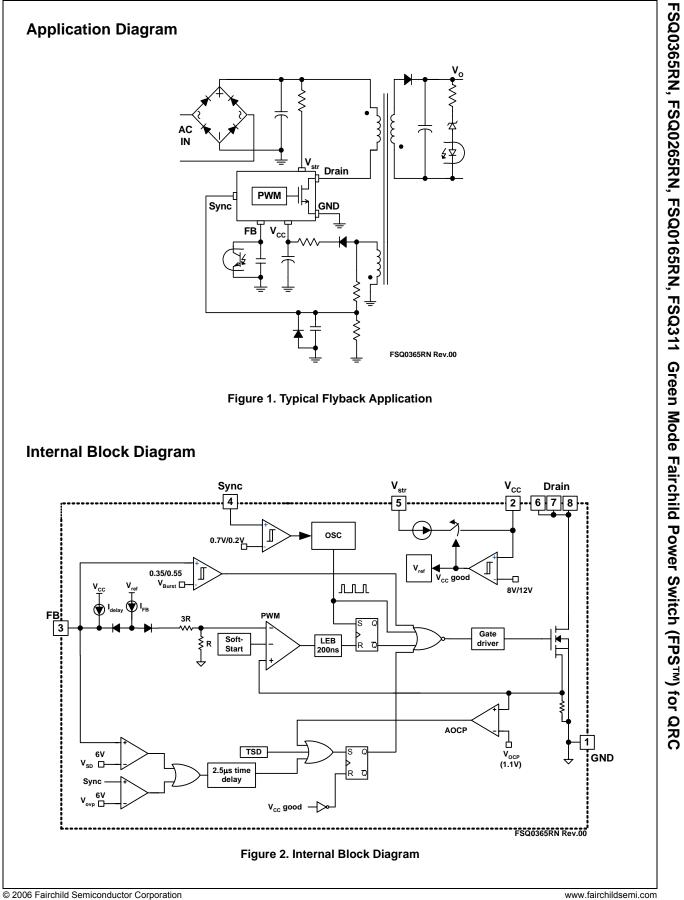
4. Maximum practical continuous power in an open frame design at 50°C ambient.

5. PB-free package per JEDEC J-STD-020B.

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## **Pin Configuration**

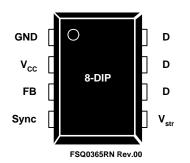


Figure 3. Pin Configuration (Top View)

## **Pin Definitions**

Pin #	Name	Description
1	GND	Ground. This pin is the control ground and the SenseFET source.
2	V <sub>CC</sub>	<b>Power Supply.</b> This pin is the positive supply input. This pin provides internal operating current for both start-up and steady-state operation.
3	FB	<b>Feedback.</b> This pin is internally connected to the inverting input of the PWM comparator. The collector of an opto-coupler is typically tied to this pin. For stable operation, a capacitor should be placed between this pin and GND. If the voltage of this pin reaches 6V, the overload protection triggers, which shuts down the FPS.
4	Sync	<b>Sync.</b> This pin is internally connected to the sync-detect comparator for quasi- resonant switching. In normal quasi-resonant operation, the threshold of the sync comparator is 0.7V/0.2V.
5	V <sub>str</sub>	<b>Start-up.</b> This pin is connected directly to the high-voltage DC link. At start-up, the internal high-voltage current source supplies internal bias and charges the external capacitor connected to the $V_{CC}$ pin. Once $V_{CC}$ reaches 12V, the internal current source is disabled.
6	Drain	SenseFET drain. High-voltage power SenseFET drain connection.
7	Drain	SenseFET drain. High-voltage power SenseFET drain connection.
8	Drain	SenseFET drain. High-voltage power SenseFET drain connection.

## **Absolute Maximum Ratings**

The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings.  $T_A = 25^{\circ}C$ , unless otherwise specified.

Symbol	Parameter	Min.	Max.	Unit	
V <sub>str</sub>	V <sub>str</sub> Pin Voltage	500		V	
V <sub>DS</sub>	Drain Pin Voltage		650		V
V <sub>CC</sub>	Supply Voltage			20	V
V <sub>FB</sub>	Feedback Voltage Range		-0.3	9.0	V
V <sub>Sync</sub>	Sync Pin Voltage		-0.3	9.0	V
		FSQ0365RN		12	
1	Drain Current Pulsed <sup>(6)</sup>	FSQ0265RN		8	A
I <sub>DM</sub>		FSQ0165RN		4	
		FSQ311		1.5	
		FSQ0365RN		230	
F	Single Pulsed Avalanche Energy <sup>(7)</sup>	FSQ0265RN		140	– mJ
E <sub>AS</sub>		FSQ0165RN		50	
		FSQ311		10	
PD	Total Power Dissipation	Total Power Dissipation			W
TJ	Operating Junction Temperature	Internally	limited	°C	
T <sub>A</sub>	Operating Ambient Temperature	-25	85	°C	
T <sub>STG</sub>	Storage Temperature ESD Capability, HBM Model <sup>(8)</sup>		-55	150	°C
			CLASS1 C		
	ESD Capability, Machine Model <sup>(8)</sup>	CLASS B			

Notes:

6. Repetitive rating: Pulse width limited by maximum junction temperature.

7. L=14mH, starting T<sub>J</sub>=25°C.

8. Meets JEDEC Standards JESD 22-A114 and 22-A115.

## Thermal Impedance<sup>(9)</sup>

Symbol	Parameter	Value	Unit	
8-DIP				
θ <sub>JA</sub> <sup>(10)</sup>	Junction-to-Ambient Thermal Resistance	80		
$\theta_{JC}^{(11)}$	Junction-to-Case Thermal Resistance 20			
$\theta_{JT}^{(12)}$	Junction-to-Top Thermal Resistance	35		

Notes:

9. All items are tested with the standards JESD 51-2 and 51-10 (DIP).

10. Free-standing, with no heat-sink, under natural convection.

11. Infinite cooling condition - refer to the SEMI G30-88.

12. Measured on the PKG top surface.

## **Electrical Characteristics**

 $T_A = 25^{\circ}C$  unless otherwise specified.

Symbol	Parame	ter	Condition	Min.	Тур.	Max.	Uni
SENSEFE	T SECTION		•				
BV <sub>DSS</sub>	Drain Source Breakdo	wn Voltage	V <sub>CC</sub> = 0V, I <sub>D</sub> = 100µA	650			V
IDSS	Zero-Gate-Voltage Dr	ain Current	V <sub>DS</sub> = 560V			100	μA
000		FSQ0365RN			3.5	4.5	
_	Drain-Source on-	FSQ0265RN			5.0	6.0	
R <sub>DS(ON)</sub>	State Resistance	FSQ0165RN	T <sub>J</sub> = 25°C, I <sub>D</sub> = 0.5A		8.0	10.0	Ω
		FSQ311	-		14.0	19.0	
		FSQ0365RN			315		
0		FSQ0265RN			550		
C <sub>SS</sub>	Input Capacitance	FSQ0165RN	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1MHz		250		pF
		FSQ311	-		162		
		FSQ0365RN			47		
-		FSQ0265RN	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1MHz		38		рF
C <sub>OSS</sub>	Output Capacitance	FSQ0165RN			25		
		FSQ311	-		18		
		FSQ0365RN			9.0		
	Reverse Transfer Capacitance	FSQ0265RN	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1MHz		17.0		
C <sub>RSS</sub>		FSQ0165RN			10.0		- pF
		FSQ311	-		3.8		
	Turn-On Delay Time	FSQ0365RN	V <sub>DD</sub> = 350V, I <sub>D</sub> = 25mA		11.2		- ns
		FSQ0265RN			20.0		
t <sub>d(on)</sub>		FSQ0165RN			12.0		
		FSQ311	-		9.5		
		FSQ0365RN			34		
	Dias Time	FSQ0265RN			15		
t <sub>r</sub>	Rise Time	FSQ0165RN	V <sub>DD</sub> = 350V, I <sub>D</sub> = 25mA		4		ns
		FSQ311			19		1
		FSQ0365RN			28.3		
		FSQ0265RN			55.0		
t <sub>d(off)</sub>	Turn-Off Delay Time	FSQ0165RN	V <sub>DD</sub> = 350V, I <sub>D</sub> = 25mA		30.0		ns
		FSQ311			33.0		
		FSQ0365RN		1	32		
		FSQ0265RN			25		
t <sub>f</sub>	Fall Time	FSQ0165RN	V <sub>DD</sub> = 350V, I <sub>D</sub> = 25mA		10		ns
		FSQ311	1		42		

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## Electrical Characteristics (Continued)

 $T_A = 25^{\circ}C$  unless otherwise specified.

Symbol	Parameter		Condition	Min.	Тур.	Max.	Unit	
CONTROL	SECTION			I.			L	
t <sub>ON.MAX</sub>	Maximum ON Time		T <sub>J</sub> = 25°C	10.5	12.0	13.5	µsec	
t <sub>B</sub>	Blanking Time			13.2	15.0	16.8	µsec	
t <sub>W</sub>	Detection Time Window		T <sub>J</sub> = 25°C, V <sub>sync</sub> = 0V		3.0		µsec	
f <sub>S</sub>	Initial Switching Frequen	су		50.5	55.6	61.7	kHz	
$\Delta f_S$	Switching Frequency Va	riation <sup>(13)</sup>	-25°C < T <sub>J</sub> < 85°C		±5	±10	%	
I <sub>FB</sub>	Feedback Source Currer		V <sub>FB</sub> = 0V	700	900	1100	μA	
D <sub>MIN</sub>	Minimum Duty Cycle		V <sub>FB</sub> = 0V			0	%	
V <sub>START</sub>				11	12	13	V	
V <sub>STOP</sub>	UVLO Threshold Voltage	2	After turn-on	7	8	9	V	
t <sub>S/S</sub>	Internal Soft-Start Time		With free-running frequency		15		ms	
BURST-MO	DDE SECTION					•	<u>.                                    </u>	
V <sub>BURH</sub>			T <sub>J</sub> = 25°C, t <sub>PD</sub> = 200ns <sup>(14)</sup>	0.45	0.55	0.65	V	
V <sub>BURL</sub>	Burst-Mode Voltages			0.25	0.35	0.45	V	
Hysteresis					200		mV	
PROTECT	ION SECTION					L		
	Peak Current Limit	FSQ0365RN	$T_J = 25^{\circ}C$ , di/dt = 240mA/µsec	1.32	1.50	1.68		
1		FSQ0265RN	$T_J = 25^{\circ}C$ , di/dt = 200mA/µsec	1.06	1.20	1.34	A	
I <sub>LIMIT</sub>		FSQ0165RN	$T_J = 25^{\circ}C$ , di/dt = 150mA/µsec	0.8	0.9	1.0		
		FSQ311	$T_J = 25^{\circ}C$ , di/dt = 100mA/µsec	0.53	0.60	0.67	1	
V <sub>SD</sub>	Shutdown Feedback Vol	tage	$V_{CC} = 15V$	5.5	6.0	6.5	V	
IDELAY	Shutdown Delay Current		V <sub>FB</sub> = 5V	4	5	6	μA	
t <sub>LEB</sub>	Leading-Edge Blanking	Fime <sup>(13)</sup>			200		ns	
V <sub>OVP</sub>	Over-Voltage Protection		$V_{CC} = 15V, V_{FB} = 2V$	5.5	6.0	6.5	V	
t <sub>OVP</sub>	Over-Voltage Protection	-		2	3	4	µsec	
T <sub>SD</sub>	Thermal Shutdown Temp	perature <sup>(13)</sup>		125	140	155	°C	
SYNC SEC	TION							
$V_{SH}$	Sync Threshold Voltage			0.55	0.70	0.85	V	
$V_{SL}$				0.14	0.20	0.26	V	
t <sub>sync</sub>	Sync Delay Time <sup>(13)(15)</sup>				300		ns	
TOTAL DE	VICE SECTION							
I <sub>OP</sub>	Operating Supply Currer (Control Part Only)	nt	V <sub>CC</sub> = 15V	1	3	5	mA	
I <sub>START</sub>	Start Current		$V_{CC} = V_{START} - 0.1V$ (before $V_{CC}$ reaches $V_{START}$ )	270	360	450	μA	
I <sub>CH</sub>	Start-up Charging Currer	nt	$V_{CC}$ = 0V, $V_{STR}$ = min. 40V	0.65	0.85	1.00	mA	
V <sub>STR</sub>	Minimum V <sub>STR</sub> Supply V	oltage			26		V	

Notes:

13. Though guaranteed, it is not tested in the mass production.

14. Propagation delay in the control IC.

15. Include gate turn-on time.

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Comparison Bety	ween FSDM0x65	RNB and FSQ-Se	ries
Function	FSDM0x65RNB	FSQ-Series	FSQ-Series Advantages
Operation method	Constant frequency PWM	Quasi-resonant operation	<ul> <li>Improved efficiency by valley switching</li> <li>Reduced EMI noise</li> </ul>
EMI reduction	Frequency modulation	Valley switching & inherent frequency modulation	Reduce EMI noise by two ways
Burst-mode operation	Fixed burst peak	Advanced burst-mode	<ul> <li>Improved standby power by valley switching also in burst-mode</li> <li>Because the current peak during burst operation is dependent on V<sub>FB</sub>, it is easier to solve audible noise</li> </ul>
Protection		AOCP	<ul> <li>Improved reliability through precise abnormal over-current protection</li> </ul>

## **Typical Performance Characteristics**

These characteristic graphs are normalized at  $T_{A}\text{=}25^{\circ}\text{C}.$ 

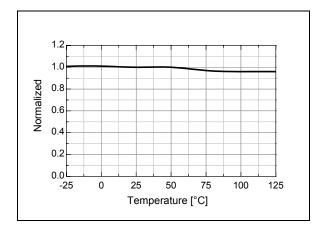


Figure 4. Operating Supply Current (I<sub>OP</sub>) vs. T<sub>A</sub>

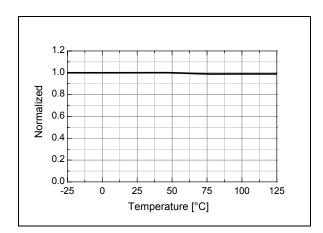


Figure 6. UVLO Stop Threshold Voltage (V<sub>STOP</sub>) vs. T<sub>A</sub>

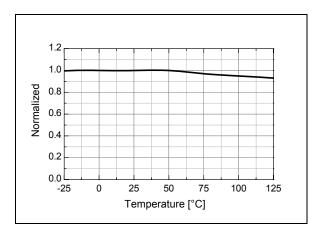
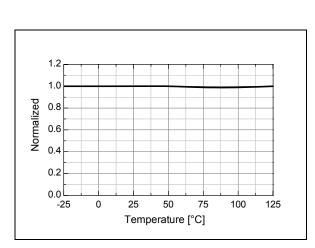
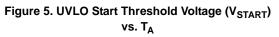


Figure 8. Initial Switching Frequency (f<sub>S</sub>) vs. T<sub>A</sub>





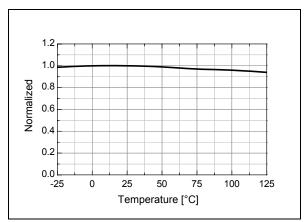


Figure 7. Start-up Charging Current (I<sub>CH</sub>) vs. T<sub>A</sub>

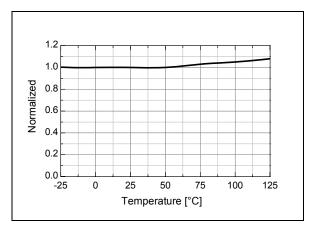


Figure 9. Maximum On Time (t<sub>ON.MAX</sub>) vs. T<sub>A</sub>

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### Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at  $T_A$ = 25°C.

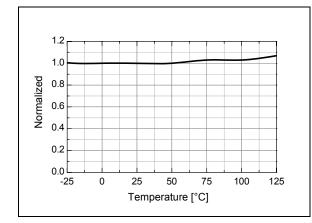


Figure 10. Blanking Time ( $t_B$ ) vs.  $T_A$ 

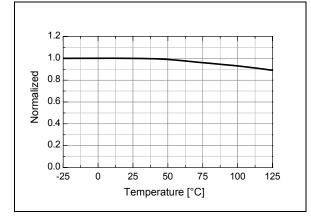


Figure 12. Shutdown Delay Current (I<sub>DELAY</sub>) vs. T<sub>A</sub>

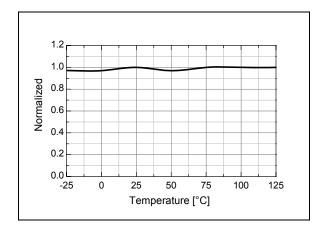


Figure 14. Burst-Mode Low Threshold Voltage (V<sub>burl</sub>) vs. T<sub>A</sub>

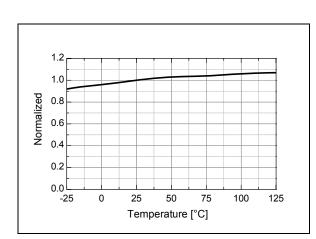


Figure 11. Feedback Source Current (I<sub>FB</sub>) vs. T<sub>A</sub>

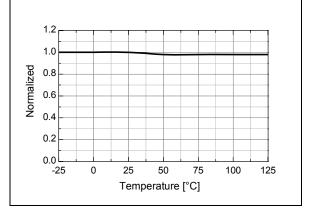


Figure 13. Burst-Mode High Threshold Voltage (V<sub>burh</sub>) vs. T<sub>A</sub>

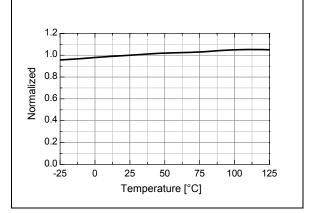


Figure 15. Peak Current Limit (I<sub>LIM</sub>) vs. T<sub>A</sub>

FSQ0365RN, FSQ0265RN, FSQ0165RN, FSQ311 Green Mode Fairchild Power Switch (FPS™) for QRC

### Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at  $T_A$ = 25°C.

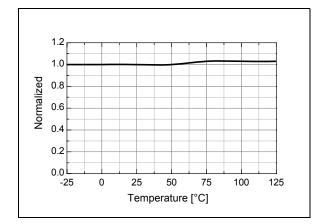


Figure 16. Sync High Threshold Voltage (V<sub>SH</sub>) vs. T<sub>A</sub>

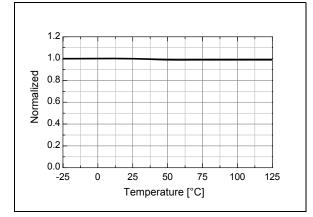


Figure 18. Shutdown Feedback Voltage ( $V_{SD}$ ) vs.  $T_A$ 

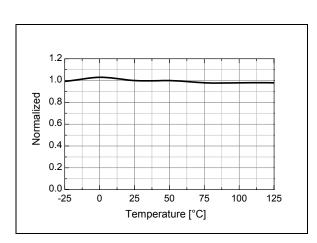


Figure 17. Sync Low Threshold Voltage (V<sub>SL</sub>) vs. T<sub>A</sub>

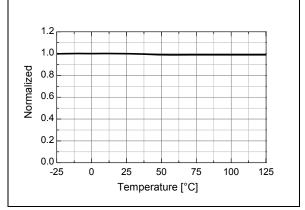


Figure 19. Over-Voltage Protection ( $V_{OV}$ ) vs.  $T_A$ 

#### **Functional Description**

**1. Startup:** At startup, an internal high-voltage current source supplies the internal bias and charges the external capacitor ( $C_a$ ) connected to the  $V_{CC}$  pin, as illustrated in Figure 20. When  $V_{CC}$  reaches 12V, the FPS begins switching and the internal high-voltage current source is disabled. The FPS continues its normal switching operation and the power is supplied from the auxiliary transformer winding unless  $V_{CC}$  goes below the stop voltage of 8V.

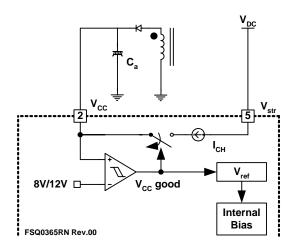


Figure 20. Start-up Circuit

2. Feedback Control: FPS employs current mode control, as shown in Figure 21. An opto-coupler (such as the FOD817A) and shunt regulator (such as the KA431) are typically used to implement the feedback network. Comparing the feedback voltage with the voltage across the  $R_{sense}$  resistor makes it possible to control the switching duty cycle. When the reference pin voltage of the shunt regulator exceeds the internal reference voltage of 2.5V, the opto-coupler LED current increases, thus pulling down the feedback voltage and reducing the duty cycle. This event typically happens when the input voltage is increased or the output load is decreased.

**2.1 Pulse-by-Pulse Current Limit:** Because current mode control is employed, the peak current through the SenseFET is limited by the inverting input of PWM comparator ( $V_{FB}^*$ ), as shown in Figure 21. Assuming that the 0.9mA current source flows only through the internal resistor (3R + R = 2.8k), the cathode voltage of diode D2 is about 2.5V. Since D1 is blocked when the feedback voltage ( $V_{FB}$ ) exceeds 2.5V, the maximum voltage of the cathode of D2 is clamped at this voltage, thus clamping  $V_{FB}^*$ . Therefore, the peak value of the current through the SenseFET is limited.

**2.2 Leading Edge Blanking (LEB):** At the instant the internal SenseFET is turned on, a high-current spike usually occurs through the SenseFET, caused by primary-side capacitance and secondary-side rectifier reverse recovery. Excessive voltage across the R<sub>sense</sub> resistor would lead to incorrect feedback operation in the current mode PWM control. To counter this effect, the FPS employs a leading edge blanking (LEB) circuit. This circuit inhibits the PWM comparator for a short time (t<sub>I FB</sub>) after the SenseFET is turned on.

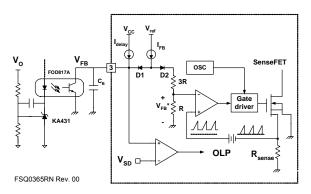


Figure 21. Pulse-Width-Modulation (PWM) Circuit

3. Synchronization: The FSQ-series employs a quasiresonant switching technique to minimize the switching noise and loss. The basic waveforms of the quasiresonant converter are shown in Figure 22. To minimize the MOSFET's switching loss, the MOSFET should be turned on when the drain voltage reaches its minimum value, as shown in Figure 22. The minimum drain voltage is indirectly detected by monitoring the V<sub>CC</sub> winding voltage, as shown in Figure 22.

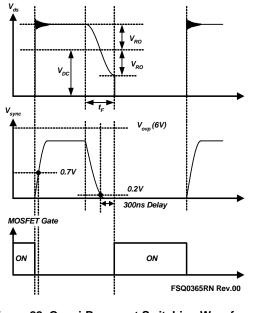


Figure 22. Quasi-Resonant Switching Waveforms

4. Protection Circuits: The FSQ-series has several self-protective functions, such as Overload Protection (OLP), Abnormal Over-Current protection (AOCP), Over-Voltage Protection (OVP), and Thermal Shutdown (TSD). All the protections are implemented as autorestart mode. Once the fault condition is detected, switching is terminated and the SenseFET remains off. This causes  $V_{CC}$  to fall. When  $V_{CC}$  falls down to the Under-Voltage Lockout (UVLO) stop voltage of 8V, the protection is reset and start-up circuit charges V<sub>CC</sub> capacitor. When the  $V_{CC}$  reaches the start voltage of 12V, the FSQ-series resumes normal operation. If the fault condition is not removed, the SenseFET remains off and V<sub>CC</sub> drops to stop voltage again. In this manner, the auto-restart can alternately enable and disable the switching of the power SenseFET until the fault condition is eliminated. Because these protection circuits are fully integrated into the IC without external components, the reliability is improved without increasing cost.

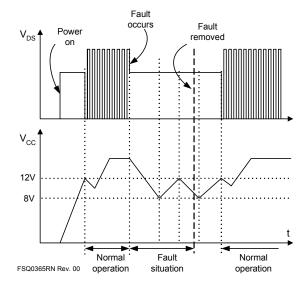


Figure 23. Auto Restart Protection Waveforms

**4.1 Overload Protection (OLP):** Overload is defined as the load current exceeding its normal level due to an unexpected abnormal event. In this situation, the protection circuit should trigger to protect the SMPS. However, even when the SMPS is in the normal operation, the overload protection circuit can be triggered during the load transition. To avoid this undesired operation, the overload protection circuit is designed to trigger only after a specified time to determine whether it is a transient situation or a true overload situation. Because of the pulse-by-pulse current limit capability, the maximum peak current through the Sense FET is limited, and therefore the maximum input power is restricted with a given input

voltage. If the output consumes more than this maximum power, the output voltage (V<sub>O</sub>) decreases below the set voltage. This reduces the current through the opto-coupler LED, which also reduces the opto-coupler transistor current, thus increasing the feedback voltage (V<sub>FB</sub>). If V<sub>FB</sub> exceeds 2.8V, D1 is blocked and the 5µA current source starts to charge CB slowly up to V<sub>CC</sub>. In this condition, V<sub>FB</sub> continues increasing until it reaches 6V, when the switching operation is terminated, as shown in Figure 24. The delay time for shutdown is the time required to charge CB from 2.8V to 6V with 5µA. A 20 ~ 50ms delay time is typical for most applications.

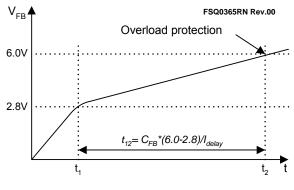
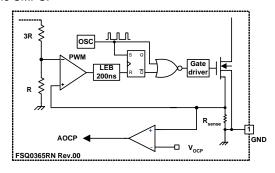
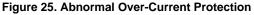


Figure 24. Overload Protection

4.2 Abnormal Over-Current Protection (AOCP): When the secondary rectifier diodes or the transformer pins are shorted, a steep current with extremely high-di/dt can flow through the SenseFET during the LEB time. Even though the FSQ-series has OLP (Overload Protection), it is not enough to protect the FSQ-series in that abnormal case, since severe current stress is imposed on the SenseFET until OLP triggers. The FSQ-series has an internal AOCP (Abnormal Over-Current Protection) circuit as shown in Figure 25. When the gate turn-on signal is applied to the power SenseFET, the AOCP block is enabled and monitors the current through the sensing resistor. The voltage across the resistor is compared with a preset AOCP level. If the sensing resistor voltage is greater than the AOCP level, the set signal is applied to the latch, resulting in the shutdown of the SMPS.





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4.3 Over-Voltage Protection (OVP): If the secondary side feedback circuit malfunctions or a solder defect causes an opening in the feedback path, the current through the opto-coupler transistor becomes almost zero. Then, V<sub>FB</sub> climbs up in a similar manner to the overload situation, forcing the preset maximum current to be supplied to the SMPS until the overload protection triggers. Because more energy than required is provided to the output, the output voltage may exceed the rated voltage before the overload protection triggers, resulting in the breakdown of the devices in the secondary side. To prevent this situation, an OVP circuit is employed. In general, the peak voltage of the sync signal is proportional to the output voltage and the FSQ-series uses a sync signal instead of directly monitoring the output voltage. If the sync signal exceeds 6V, an OVP is triggered, shutting down the SMPS. To avoid undesired triggering of OVP during normal operation, the peak voltage of the sync signal should be designed below 6V.

**4.4 Thermal Shutdown (TSD):** The SenseFET and the control IC are built in one package. This makes it easy for the control IC to detect the abnormal over temperature of the SenseFET. If the temperature exceeds  $\sim$ 150°C, the thermal shutdown triggers.

**5. Soft-Start:** The FPS has an internal soft-start circuit that increases PWM comparator inverting input voltage with the SenseFET current slowly after it starts up. The typical soft-start time is 15ms, The pulse width to the power switching device is progressively increased to establish the correct working conditions for transformers, inductors, and capacitors. The voltage on the output capacitors is progressively increased with the intention of smoothly establishing the required output voltage. This mode helps prevent transformer saturation and reduces stress on the secondary diode during startup.

**6.** Burst Operation: To minimize power dissipation in standby mode, the FPS enters burst-mode operation. As the load decreases, the feedback voltage decreases. As shown in Figure 26, the device automatically enters burst-mode when the feedback voltage drops below V<sub>BURL</sub> (350mV). At this point, switching stops and the output voltages start to drop at a rate dependent on standby current load. This causes the feedback voltage to rise. Once it passes V<sub>BURH</sub> (550mV), switching resumes. The feedback voltage then falls and the process repeats. Burst-mode operation alternately enables and disables switching of the power SenseFET, thereby reducing switching loss in standby mode.

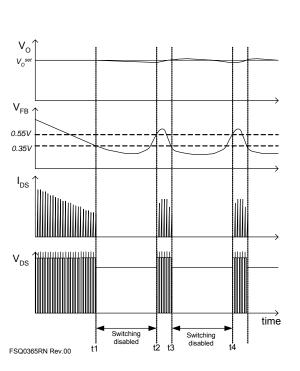
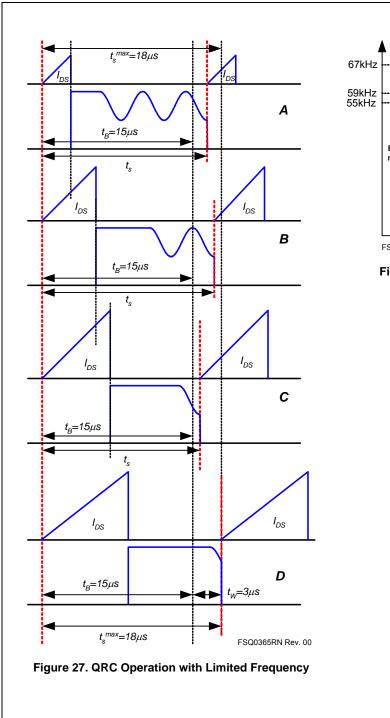


Figure 26. Waveforms of Burst Operation

**7. Switching Frequency Limit:** To minimize switching loss and EMI (Electromagnetic Interference), the MOSFET turns on when the drain voltage reaches its minimum value in quasi-resonant operation. However, this causes switching frequency to increases at light load conditions. As the load decreases, the peak drain current diminishes and the switching frequency increases. This results in severe switching losses at light-load condition, as well as intermittent switching and audible noise. Because of these problems, the quasi-resonant converter topology has limitations in a wide range of applications.

To overcome this problem, FSQ-series employs a frequency-limit function, as shown in Figures 27 and 28. Once the SenseFET is turned on, the next turn-on is prohibited during the blanking time ( $t_B$ ). After the blanking time, the controller finds the valley within the detection time window ( $t_W$ ) and turns on the MOSFET, as shown in Figures 27 and 28 (Cases A, B, and C). If no valley is found during  $t_W$ , the internal SenseFET is forced to turn on at the end of  $t_W$  (Case D). Therefore, our devices have a minimum switching frequency of 67kHz, as shown in Figure 28.



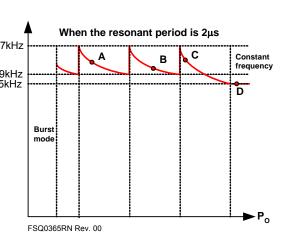


Figure 28. Switching Frequency Range

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## **Application Information**

Application	FPS Device	Input Voltage Range	Rated Output Power	Output Voltage (Max. Current)
DVD Player Power Supply	FSQ0365RN	85-265V <sub>AC</sub>	19W	5.1V (1.0A) 3.4V (1.0A) 12V (0.4A) 16V (0.3A)

#### Features

- High efficiency ( >77% at universal input)
- Low standby mode power consumption (<1W at 230V<sub>AC</sub> input and 0.5W load)
- Reduce EMI noise through Quasi-Resonant Operation
- Enhanced system reliability through various protection functions
- Internal soft-start (15ms)

#### **Key Design Notes**

- The delay time for overload protection is designed to be about 30ms with C107 of 47nF. If faster/slower triggering of OLP is required, C107 can be changed to a smaller/larger value (eg. 100nF for 60ms).
- The input voltage of V<sub>sync</sub> must be higher than -0.3V. By proper voltage sharing by R106 & R107 resistors, the input voltage can be adjusted.
- The SMD-type 100nF capacitor must be placed as close as possible to V<sub>CC</sub> pin to avoid malfunction by abrupt pulsating noises and to improved surge immunity.

#### C209 16V, 0.3A RT101 5D-9 C201 470µF 35V С202 470µF 35V C104 10nF 630V R105 ↓ 100kg R102 56kQ C210 ≶ 2 C103 33µF 400V D101 R108 12V. 0.4A С203 470µF 35V 170µ 35V IC101 2010 Dra 5.1V, 1A R103 C205 С206 1000µ 10V D203 SB360 C105 47nF 50V 100 R104 12kg 5 L204 3.4V, 1A С208 1000µl 10V C110 33pF 50V C207 D204 SB360 1000µF 10V R106 6.2kQ LF101 7 C302 3.3n R201 510Q C101 100nF R203 6.2kQ £ R202 1kQ C209 100nF R204 20kΩ IC202 FOD817A TNR 10D471K F101 FUSE IC201 KA431 R205 6kΩ AC IN FSQ0365RN Rev:00 Figure 29. Demo Circuit

#### 1. Schematic

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## 2. Transformer

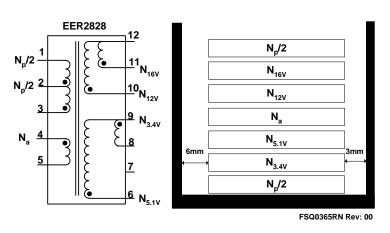


Figure 30. Transformer Schematic Diagram

## 3. Winding Specification

No	Pin (s→f)	Wire	Turns	Winding Method
N <sub>p</sub> /2	$3 \rightarrow 2$	$0.25^{\phi}  imes 1$	50	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	0mm, 2 Layers		•
N <sub>3.4V</sub>	$9 \rightarrow 8$	$0.33^{\varphi} \times 2$	4	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	0mm, 2 Layers		· ·
N <sub>5V</sub>	$6 \rightarrow 9$	$0.33^{\varphi} \times 1$	2	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	0mm, 2 Layers		
Na	$4 \rightarrow 5$	$0.25^{\phi}  imes 1$	16	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	Omm, 2 Layers		
N <sub>12V</sub>	$10 \rightarrow 12$	$0.33^{\varphi}\times 3$	14	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	Omm, 3 Layers		
N <sub>16V</sub>	$11 \rightarrow 12$	$0.33^{\varphi}\times 3$	18	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	0mm, 2 Layers		•
N <sub>p</sub> /2	$2 \rightarrow 1$	$0.25^{\phi}  imes 1$	50	Center Solenoid Winding
Insulation: F	Polyester Tape t = 0.050	0mm, 2 Layers	•	•

## 4. Electrical Characteristics

	Pin	Specification	Remarks
Inductance	1 - 3	1.4mH ± 10%	100kHz, 1V
Leakage	1 - 3	25µH Max.	Short all other pins

## 5. Core & Bobbin

- Core: EER2828 (Ae=86.66mm<sup>2</sup>)
- Bobbin: EER2828

## 6. Demo Board Part List

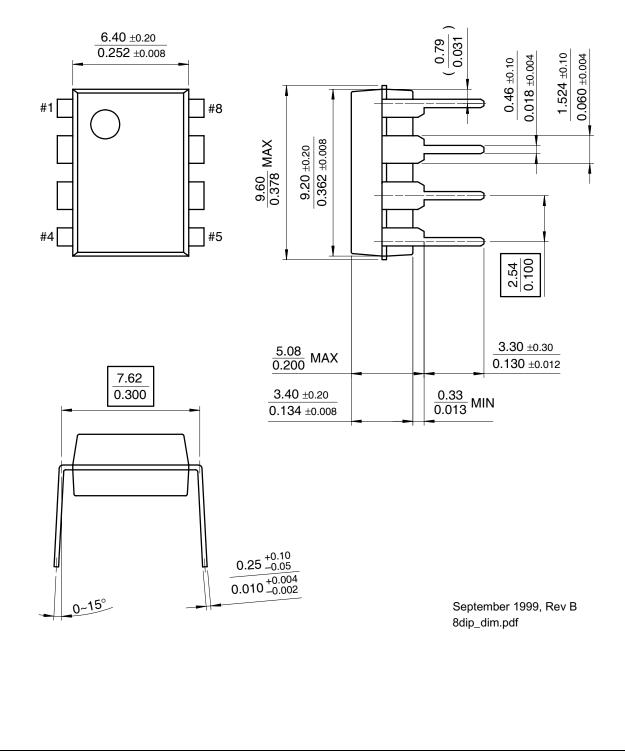
Part	Value	Note	Part	Value	Note
Resistor				Indu	ctor
R102	56kΩ	1W	L201	10µH	
R103	5Ω	1/2W	L202	10µH	
R104	12kΩ	1/4W	L203	4.9µH	
R105	100kΩ	1/4W	L204	4.9µH	
R106	6.2kΩ	1/4W		Dio	de
R107	6.2kΩ	1/4W	D101	IN4007	
R108	62Ω	1W	D102	IN4004	
R201	510Ω	1/4W	ZD101	1N4746A	
R202	1kΩ	1/4W	D103	1N4148	
R203	6.2kΩ	1/4W	D201	UF4003	
R204	<b>20k</b> Ω	1/4W	D202	UF4003	
R205	6kΩ	1/4W	D203	SB360	
Capacitor		D204	SB360		
C101	100nF/275V <sub>AC</sub>	Box Capacitor			
C102	100nF/275V <sub>AC</sub>	Box Capacitor	IC		C
C103	33µF/400V	Electrolytic Capacitor	IC101	FSQ0365RN	FPS™
C104	10nF/630V	Film Capacitor	IC201	KA431 (TL431)	Voltage reference
C105	47nF/50V	Mono Capacitor	IC202	FOD817A	Opto-coupler
C106	100nF/50V	SMD (1206)		Fu	se
C107	22µF/50V	Electrolytic Capacitor	Fuse	2A/250V	
C110	33pF/50V	Ceramic Capacitor		NT	C
C201	470µF/35V	Electrolytic Capacitor	RT101	5D-9	
C202	470µF/35V	Electrolytic Capacitor		Bridge	Diode
C203	470µF/35V	Electrolytic Capacitor	BD101	2KBP06M2N257	Bridge Diode
C204	470µF/35V	Electrolytic Capacitor		Line	Filter
C205	1000µF/10V	Electrolytic Capacitor	LF101	40mH	
C206	1000µF/10V	Electrolytic Capacitor		Transf	ormer
C207	1000µF/10V	Electrolytic Capacitor	T101		
C208	1000µF/10V	Electrolytic Capacitor		Varis	stor
C209	100nF /50V	Ceramic Capacitor	TNR	10D471K	

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## **Package Dimensions**

#### 8-DIP

Dimensions are in millimeters unless otherwise noted.



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Build it Now™	l <sup>2</sup> C™	PACMAN™	SPM™	TinyPower™
CoolFET™	<i>i-Lo</i> ™	POP™	Stealth™	TinyPWM™
CROSSVOLT™	ImpliedDisconnect™	Power247™	SuperFET™	TruTranslation™
DOME™	IntelliMAX™	PowerEdge™	SuperSOT™-3	UHC™
EcoSPARK™	ISOPLANAR™	PowerSaver™	SuperSOT™-6	UltraFET®
E <sup>2</sup> CMOS™	LittleFET™	PowerTrench®	SuperSOT™-8	UniFET™
EnSigna™	MICROCOUPLER™	QFET <sup>®</sup>	SyncFET™	VCX™
FACT™	MicroFET™	QS™	TCM™	Wire™
FACT Quiet Series™	MicroPak™	QT Optoelectronics™	TinyBoost™	
FAST <sup>®</sup>	MICROWIRE™	Quiet Series™		
FASTr™	MSX™	RapidConfigure™	Across the board. Arour	id the world.™
FPS™	MSXPro™	RapidConnect™	Programmable Active D	roop™
FRFET™	OCX™	ScalarPump™	The Power Franchise <sup>®</sup>	

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